 arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,697	NAGAI ET AL.	
Examiner	Art Unit	
Nhon T. Diep	2621	

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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East text Search VO, Tum	6/16/06	N.D.
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